

DualPrecisionMonostable

General Description

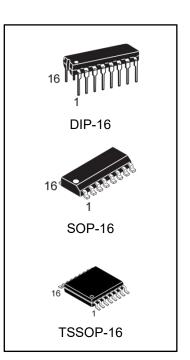
The CD4538B is a dual, precision monostable multivibrator with independent trigger and reset controls. The device is retriggerable and resettable, and the control inputs are inter- nally latched. Two trigger inputs are provided to allow either rising or falling edge triggering. The reset inputs are active low and prevent triggering while active. Precise control of output pulse-width has been achieved using linear CMOS techniques. The pulse duration and accuracy are deter-mined by external components RX and CX. The device does not allow the timing capacitor to discharge through the tim- ing pin on power-down condition. For this reason, no exter-nal protection resistor is required in series with the timing pin. Input protection from static discharge is provided on all pins.

Features

- Wide supply voltage range:5.0V to 15V
- High noise immunity:0.45 V_{CC} (typ.)
- Low power TTL compatibility:Fan out of 2 driving 74L or 1 driving 74LS
- New formula: PWout = RC (PW in seconds, R in Ohms, C in Farads)
- ±1.0% pulse-width variation from part to part (typ.)
- Wide pulse-width rang:1 µS to ∞
- Separate latched reset inputs
- Symmetrical output sink and source capability
- Low standby current:5 nA (typ.)@ 5 VDC
- Pin compatible to CD4528B

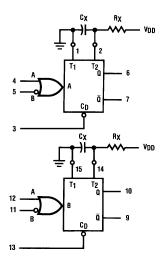
Ordering Information

DEVICE	Package Type	MARKING	Packing	Packing Qty
CD4538BE	DIP-16	CD4538B	TUBE	1000pcs/box
CD4538BM/TR	SOP-16	CD4538B	REEL	2500pcs/reel
CD4538BMT/TR	TSSOP-16	CD4538B	REEL	2500pcs/reel





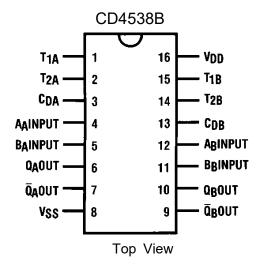
Block and Connection Diagrams



RX and CX are External Components

V_{DD}-Pin 16 V_{SS}-Pin 8

Dual-In-Line Package



Truth Table

	Inputs		Out	puts
Clear	А	В	Q	Q
L	Х	Х	L	н
X	Н	Х	L	н
X	Х	L	L	н
н	L	\downarrow	М	W
Н	↑ (Н	М	W

H= High Level I	
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L= Low Level

- ↑= Transition from Low to High
- \downarrow = Transition from High to Low
- M= One High Level Pulse
- W= One Low Level Pulse

X= Irrelevant



Maximum Ratings

Symbol	Parameter	Min	Мах	Unit	
VDD	DC Supply Voltage	-0.5	+18	V _{DC}	
V _{IN}	Input Voltage	-0.5	0.5	V _{DC}	
Ts	Storage Temperature Range	Storage Temperature Range			
PD	Power Dissipation	Dual-In-Line	7(00	mW
FD		Small Outline	50	00	mW
T_L	Lead Temperature	Soldering, 10 seconds	26	60	°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed, they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for acutal device operation.

Note 2: VSS e 0V unless otherwise specified.

Recommended Operating Conditions

Symbol	Parameter	Min	Max	Unit
VDD	DC Supply Voltage	5	15	V _{DC}
V _{IN}	Input Voltage	0	-	V _{DC}
T _A	Operating Temperature Range	-40	+85	°C

DC Electrical Characteristics

0h.e.l	Demonstern	Conditions		0°C		+25°C		+85°C		
Symbol	Parameter	Conditions	Min	Max	Min	Тур	Max	Min	Max	Units
IDD	Quiescent Device Current	VDD=5V VIH=VDD VDD=10V VIL=VSS VDD=15V All Outputs Open		20 40 80		0.005 0.010 0.015	20 40 80		150 300 600	μA
VOL	Low Level Output Voltage	VDD=5V VDD=10V IIol<1 μA VDD=15V VIH=VDD,ViL=Vss		0.05 0.05 0.05		0 0 0	0.05 0.05 0.05		0.05 0.05 0.05	v
VOH	High Level Output Voltage	VDD=5V VDD=10V llol<1 µA VDD=15V VIH=VDD,ViL=Vss	4.95 9.95 14.95		4.95 9.95 14.95	5 10 15		4.95 9.95 14.95		v
VIL	Low Level Input Voltage	llol<1 μA VDD=5V,VO=0.5V of 4.5V VDD=10V,VO=1.0V of 9.0V VDD=15V,VO=1.5V of 13.5V		1.5 3.0 4.0		2.25 4.50 6.75	1.5 3.0 4.0		1.5 3.0 4.0	v
VIH	High Level Input Voltage	llol<1 μA VDD=5V,VO=0.5V of 4.5V VDD=10V,VO=1.0V of 9.0V VDD=15V,VO=1.5V of 13.5V	3.5 7.0 11.0		3.5 7.0 11.0	2.75 5.50 8.25		3.5 7.0 11.0		V
IOL	Low Level Output Current (Note 3)	VDD=5V,VO 0.4V VDD=10V,VO=0.5V VDD=15V,VO=1.5V VIL=VSS	0.52 1.3 3.6		0.44 1.1 3.0	0.88 2.25 8.8		0.36 0.9 2.4		mA
ЮН	High Level Output Current (Note 3)	VDD=5V,VO=4.6 VDD=10V,VO=9.5V VDD=15V,VO=13.5V	-0.52 -1.3 -3.6		-0.44 -1.1 -3.0	-0.88 -2.25 -8.8		-0.36 -0.9 -2.4		mA
IIN	Input Current, Pin2 or 14	VDD=15V, VIN=0V or 15V		±0.02		±10 ⁻⁵	±0.05		±0.5	μA
IIN	Input Current Other Inputs	VDD=15V, VIN=0V or 15V		±0.3		±10 ⁻⁵	±0.3		±1.0	μA

Note 3: IOH and IOL are tested one output at a time.



AC Electrical Characteristics

* TA = 25°C, C_L = 50 pF, and tr= tf= 20 ns unless otherwise specified	b
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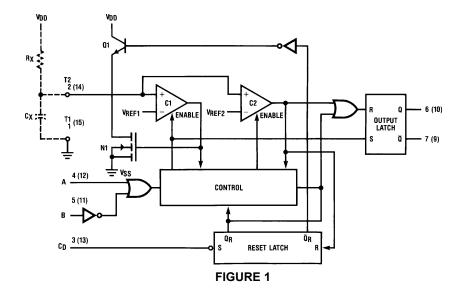
Symbol	Parameter	Condition	ns	Min	Тур	Max	Units
ttlh, tthl	Output Transition Time	$V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$			100 50 40	200 100 80	ns
tplh, tphl	Propagation Delay Time	Trigger Operation— A orB toQ orQ $V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$ Reset Op <u>er</u> ation— C_{D} toQ orQ $V_{DD}=5V$	-		300 150 100 250 125	600 300 220 500 250	ns
		V _{DD} =10V V _{DD} =15V			95	190	
tWL, tWH	Minimum Input Pulse Width A, B, or C _D	V _{DD} =5V V _{DD} =10V V _{DD} =15V			35 30 25	70 60 50	ns
^t RR	Minimum Retrigger Time	$V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$			0	0 0 0	ns
CIN	Input Capacitance	Pin 2 or 14 Other Inputs			10 5	7.5	pF
		Rχ=100 kΩ	V _{DD} =5V V _{DD} =10V V _{DD} =15V	208 211 216	226 230 235	244 248 254	μS
PWOUT	Output Pulse Width (Q or Q) (Note : For Typical Distribution, see Figure 9)	Rχ=100 kΩ Cχ=0.1μF	V _{DD} =5V V _{DD} =10V V _{DD} =15V	8.83 9.02 9.20	9.60 9.80 10.00	10.37 10.59 10.80	ms
		Rχ=100kΩ Cχ=10.0 μF	V _{DD} =5V V _{DD} =10V V _{DD} =15V	0.87 0.89 0.91	0.95 0.97 0.99	1.03 1.05 1.07	S
Pulse Width Match between Circuits in the Same Package $C\chi$ =0.1 µF, R χ =100 k Ω		Rχ=100 kΩ Cχ=0.1 μF	V _{DD} =5V V _{DD} =10V V _{DD} =15V		±1 ±1 ±1		%
Operatii	ng Conditions						
RX CX	External Timing Resistance External Timing Capacitance			5.0 0		** No Limit	kΩ pF

Note 4:AC parameters are guaranteed by DC correlated testing.

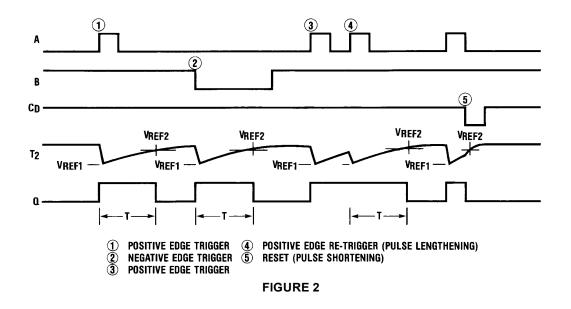
Note 5:The maximum usable resistance R_x is a function of the leakage of the Capacitor C_x , leakage of the CD4538B, and leakage due to board layout, surface resistance, etc.



Logic Diagram



Theory of Operation





Trigger Operation

The block diagram of the CD4538B is shown in Figure 1, with circuit operation following.

As shown in Figures 1 and 2, before an input trigger occurs, the monostable is in the quiescent state with the Q output low, and the timing capacitor C_X completely charged to V_{DD} . When the trigger input A goes from V_{SS} to V_{DD} (while inputs B and C_D are held to V_{DD}) a valid trigger is recog- nized, which turns on comparator C1 and N-Channel tran- sistor N1⁽¹⁾. At the same time the output latch is set. With transistor N1 on, the capacitor C_X rapidly discharges toward V_{SS} until V_{REF1} is reached. At this point the output of com- parator C1 changes state and transistor N1 turns off. Com- parator C1 then turns off while at the same time comparator C2 turns on. With transistor N1 off, the capacitor C_X begins to charge through the timing resistor, RX, toward V_{DD} . When the voltage across C_X equals V_{REF2} , comparator C2 changes state causing the output latch to reset (Q goes low) while at the same time disabling comparator C2. This ends the timing cycle with the monostable in the quiescent state, waiting for the next trigger.

A valid trigger is also recognized when trigger input B goes from V_{DD} to V_{SS} (while input A is at VSS and input CD is at V_{DD})[®].

It should be noted that in the quiescent state C_X is fully charged to V_{DD} , causing the current through resistor R_X to be zero. Both comparators are "off" with the total device current due only to reverse junction leakages. An added feature of the CD4538B is that the output latch is set via the input trigger without regard to the capacitor voltage. Thus, propagation delay from trigger to Q is independent of the value of C_X , R_X , or the duty cycle of the input waveform.

Retrigger Operation

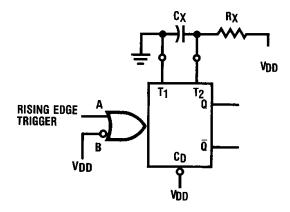
The CD4538B is retriggered if a valid trigger occurs [®] fol lowed by another valid triggerm [®] before the Q output has returned to the quiescent (zero) state. Any retrigger, after the timing node voltage at pin 2 or 14 has begun to rise from VREF1, but has not yet reached VREF2, will cause an in crease in output pulse width T. When a valid retrigger is initiatedm[®], the voltage at T2 will again drop to VREF1 before progressing along the RC charging curve toward VDD. The Q output will remain high until time T, after the last valid retrigger.

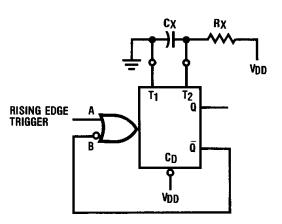
Reset Operation

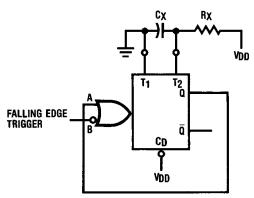
The CD4538B may be reset during the generation of the output pulse. In the reset mode of operation, an input pulse on C_D sets the reset latch and causes the capacitor to be fast charged to V_{DD} by turning on transistor Q1^(a). When the voltage on the capacitor reaches V_{REF2}, the reset latch will clear and then be ready to accept another pulse. If the C_D input is held low, any trigger inputs that occur will be inhibited and the Q and \overline{Q} outputs of the output latch will not change. Since the Q output is reset when an input low level is detected on the C_D input, the output pulse T can be made significantly shorter than the minimum pulse width specification



Typical Applications







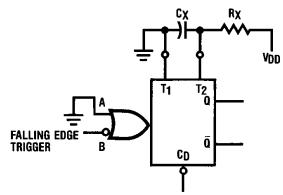


FIGURE 3. Retriggerable Monostables Circuitry

FIGURE 4. Non-Retriggerable Monostables Circuitry

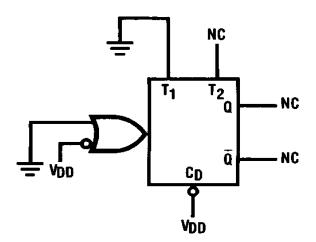


FIGURE 5. Connection of Unused Sections



Typical Applications

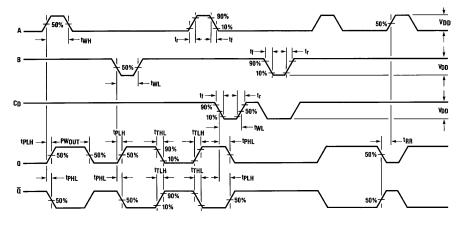
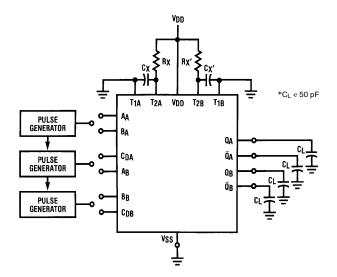
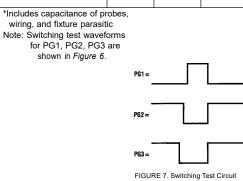


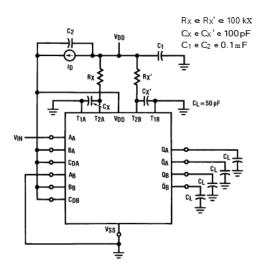
FIGURE 6. Switching Test Waveforms

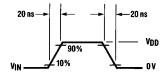


Input	Connections
πipuι	Connections

Characteristics	CD	А	В
^t PLH, ^t PHL, ^t TLH, ^t THL PWOUT, ^t WH, ^t WL	V _{DD}	PG1	V _{DD}
^t PLH, ^t PHL, ^t TLH, ^t THL PWOUT, ^t WH, ^t WL	V _{DD}	V _{SS}	PG2
^t PLH(R) ^{, t} PHL(R) ^{, t} WH ^{, t} WL	PG3	PG1	PG2



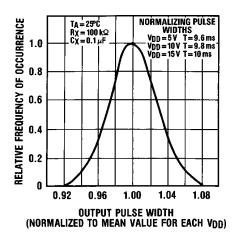


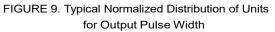


Duty Cycle e 50% FIGURE8.Power Dissipation Test Circuit and Waveforms



Typical Applications





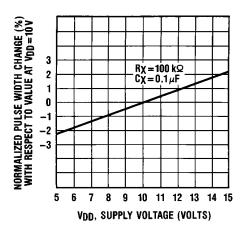


FIGURE 10. Typical Pulse Width Variation as a Function of Supply Voltage V_{DD}

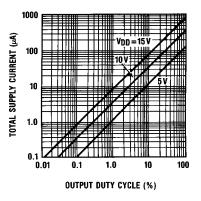


FIGURE 11. Typical Total Supply Current VersusFIGURE Output Duty Cycle, $R_X = 100 \text{ k}\Omega$, $C_L = 50 \text{ pF}$, $C_X = 100 \text{ pF}$, One Monostable Switching Only

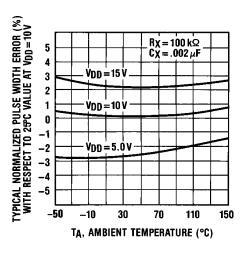


FIGURE 12. Typical Pulse Width Error Versus Temperature

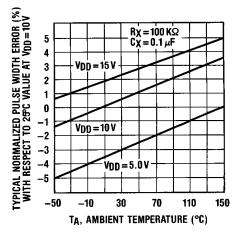


FIGURE 13. Typical Pulse Width Error Versus Temperature

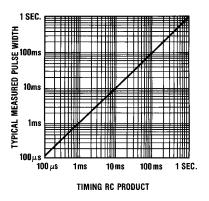
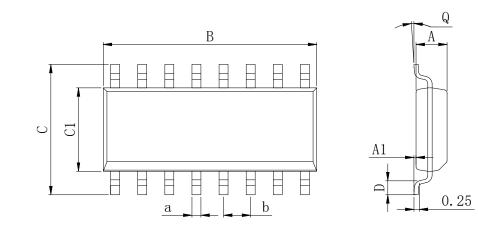


FIGURE 14. Typical Pulse Width Versus Timing RC Product



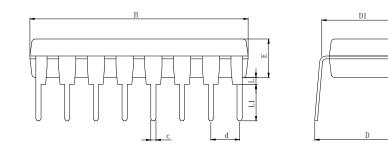
Physical Dimensions

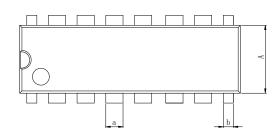
SOP16



Dimensions In Millimeters(SOP16)												
Symbol:	A	A1	В	С	C1	D	Q	а	b			
Min:	1.35	0.05	9.80	5.80	3.80	0.40	0°	0.35	1.27 BSC			
Max:	1.55	0.20	10.0	6.20	4.00	0.80	8°	0.45	1.27 030			

DIP16



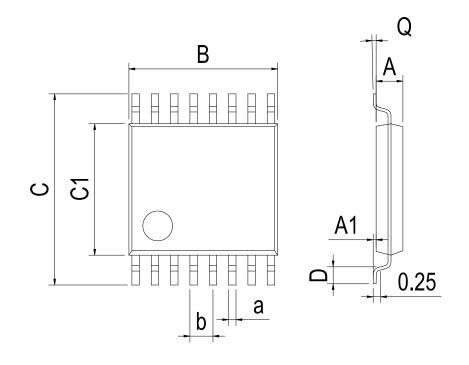


Dimensions In Millimeters(DIP16)												
Symbol:	A	В	D	D1	E	L	L1	а	b	с	d	
Min:	6.10	18.94	8.40	7.42	3.10	0.50	3.00	1.50	0.85	0.40	2.54 BSC	
Max:	6.68	19.56	9.00	7.82	3.55	0.70	3.60	1.55	0.90	0.50	2.34 030	



Physical Dimensions

TSSOP16



Dimensions In Millimeters(TSSOP16)									
Symbol:	A	A1	В	С	C1	D	Q	а	b
Min:	0.85	0.05	4.90	6.20	4.30	0.40	0°	0.20	0.65 BSC
Max:	0.95	0.20	5.10	6.60	4.50	0.80	8°	0.25	



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